MIC5841/5842



8-Bit Serial-Input Latched Drivers

General Description

Using BiCMOS technology, the MIC5841/5842 integrated circuits were fabricated to be used in a wide variety of peripheral power driver applications. The devices each have an eight-bit CMOS shift register, CMOS control circuitry, eight CMOS data latches, and eight bipolar current-sink Darlington output drivers.

These two devices differ only in maximum voltage ratings. The MIC5842 offers premium performance with a minimum output breakdown voltage rating of 80V (50V sustaining). The drivers can be operated with a split supply where the negative supply is down to -20V.

The 500 mA outputs, with integral transient-suppression diodes, are suitable for use with lamps, relays, solenoids and other inductive loads.

These devices have improved speed characteristics. With a 5V logic supply, they will typically operate faster than 5 MHz. With a 12V supply, significantly higher speeds are obtained. The CMOS inputs are compatible with standard CMOS, PMOS, and NMOS logic levels. TTL or DTL circuits may require the use of appropriate pull-up resistors. By using the serial data output, the drivers can be cascaded for interface applications requiring additional drive lines.

The MIC5840 family is available in DIP, PLCC, and SOIC packages. Because of limitations on package power dissipation, the simultaneous operation of all drivers at maximum rated current might require a reduction in duty cycle. A copper-alloy lead frame provides for maximum package power dissipation.

Features

- 3.3 MHz Minimum Data-Input Rate
- CMOS, PMOS, NMOS, TTL Compatible
- Internal Pull-Up/Pull-Down Resistors
- Low-Power CMOS Logic and Latches
- High-Voltage Current-Sink Outputs
- Output Transient-Protection Diodes
- Single or Split Supply Operation

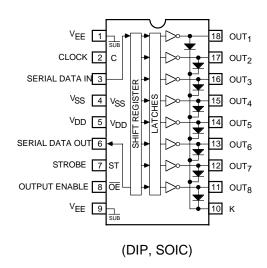
Ordering Information

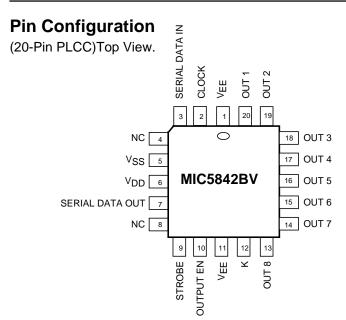
Part Number	Temperature Range	Package
MIC5841BN	-40°C to +85°C	18-Pin Plastic DIP
MIC5841BV	–40°C to +85°C	20-Pin PLCC
MIC5841BWM	–40°C to +85°C	18-Pin Wide SOIC
MIC5842BN	–40°C to +85°C	18-Pin Plastic DIP
MIC5842BV	–40°C to +85°C	20-Pin PLCC
MIC5842BWM	–40°C to +85°C	18-Pin Wide SOIC

Functional Diagram

SERIAL DATA IN 3 8-BIT SERIAL-PARALLEL SHIFT REGISTER VSS 4 LATCHES OUTPUT ENABLE (ACTIVE LOW) NOS Bipolar VEE OUTPUT ENABLE (ACTIVE LOW)

Pin Configuration





Absolute Maximum Ratings (Note 1, 2, 3)

at 25°C Free-Air Temperature and V_{SS} = 0V

Output Voltage, V_{CE} (MIC5841) 50V (MIC5842) 80V Output Voltage, VCE(SUS) (MIC5841) (Note 1) 35V (MIC5842) 50V Logic Supply Voltage, VDD 15V V_{DD} with Reference to V_{EE} 25V Emitter Supply Voltage, VEE -20V Input Voltage Range, VIN -0.3V to $V_{DD} + 0.3V$ Continuous Output Current, IOUT 500mA Package Power Dissipation, PD (Note 2) 1.82W Operating Temperature Range, TA -55°C to +85°C Storage Temperature Range, TS -65°C to +150°C

Note 1: For Inductive load applications.

Note 2: Derate at the rate of $18.2 \text{mW}/^{\circ}\text{C}$ above $T_A = 25^{\circ}\text{C}$ (Plastic DIP)

Note 3: CMOS devices have input-static protection but are susceptible to damage when exposed to extremely high static electrical charges.

Electrical Characteristics at $T_A = 25^{\circ}C\ V_{DD} = 5V$, $V_{SS} = V_{EE} = 0V$ (unless otherwise noted)

		Applicable			Limits	
Characteristic	Symbol	Devices	Test Conditions	Min.	Max.	Unit
Output Leakage Current	I _{CEX}	MIC5841	V _{OUT} = 50V		50	μА
			V _{OUT} = 50V, T _A = +70°C		100	1
		MIC5842	V _{OUT} = 80V		50	1
			$V_{OUT} = 80V, T_A = +70^{\circ}C$		100	1
Collector-Emitter	V _{CE} (SAT)	Both	I _{OUT} = 100mA		1.1	V
Saturation Voltage			I _{OUT} = 200mA		1.3]
			I _{OUT} = 350mA, V _{DD} = 7.0V		1.6	
Collector-Emitter	V _{CE(SUS)}	MIC5841	I _{OUT} = 350mA, L = 2mH	35		V
Sustaining Voltage	(Note 5)	MIC5842	I _{OUT} = 350mA, L = 2mH	50		
Input Voltage	V _{IN(0)}	Both			0.8	V
	V _{IN(1)}	Both	V _{DD} = 12V	10.5]
			V _{DD} = 10V	8.5]
			V _{DD} = 5.0V (See Note 4)	3.5		
Input Resistance	R _{IN}	Both	V _{DD} = 12V	50		kΩ
			V _{DD} = 10V	50		
			V _{DD} = 5.0V	50		
Supply Current	I _{DD(ON)}	Both	All Drivers ON, V _{DD} = 12V		16	mA
			All Drivers ON, V _{DD} = 10V		14	
			All Drivers ON, V _{DD} = 5.0V		8.0	
	I _{DD(OFF)}	Both	All Drivers OFF, V _{DD} = 12V		2.9	
			All Drivers OFF, V _{DD} = 10V		2.5]
			All Drivers OFF, V _{DD} = 5.0V		1.6	
Clamp Diode	I _R	MIC5841	V _R = 50V		50	μА
Leakage Current		MIC5842	V _R = 80V		50]
Clamp Diode Forward Voltage	V _F	Both	I _F = 350mA		2.0	V

Note 4: Operation of these devices with standard TTL may require the use of appropriate pull-up resistors to insure an input logic HIGH.

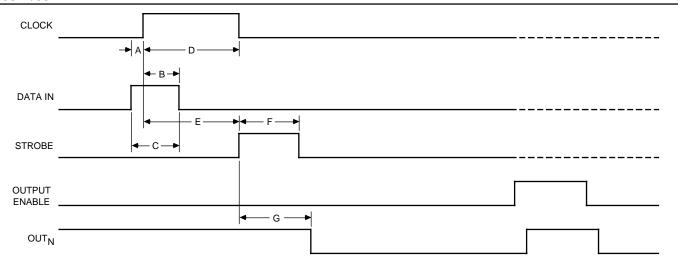
Note 5: Not 100% tested. Guaranteed by design.

$\textbf{Electrical Characteristics} \ \, \text{T}_{A} = -55^{\circ}\text{C}, \, \text{V}_{DD} = 5\text{V}, \, \text{V}_{SS} = \text{V}_{EE} = 0\text{V} \, \, \text{(unless otherwise noted)}$

				Limits	
Characteristic	Symbol	Test Conditions	Min.	Max.	Unit
Output Leakage Current	ICEX	V _{OUT} = 80V		50	μΑ
Collector-Emitter	V _{CE(SAT)}	I _{OUT} = 100mA		1.3	V
Saturation Voltage		I _{OUT} = 200mA		1.5	
		$I_{OUT} = 350 \text{mA}, V_{DD} = 7.0 \text{V}$		1.8	
Input Voltage	V _{IN(0)}			0.8	V
	V _{IN(1)}	V _{DD} = 12V	10.5		1
		V _{DD} = 5.0V	3.5		
Input Resistance	R _{IN}	V _{DD} = 12V	35		kΩ
		V _{DD} = 10V	35		
		V _{DD} = 5.0V	35		1
Supply Current	I _{DD(ON)}	All Drivers ON, V _{DD} = 12V		16	mA
		All Drivers ON, V _{DD} = 10V		14	
		All Drivers ON, V _{DD} = 5.0V		10	
	I _{DD(OFF)}	All Drivers OFF, V _{DD} = 12V		3.5	1
		All Drivers OFF, V _{DD} = 5.0V		2.0	

Electrical Characteristics $T_A = +125$ °C, $V_{DD} = 5V$, $V_{SS} = V_{EE} = 0V$ (unless otherwise noted)

					Limits	
Characteristic	Symbol	Test Conditions	Test Conditions			Unit
Output Leakage Current	I _{CEX}		V _{OUT} = 80V		500	μΑ
Collector-Emitter	V _{CE} (SAT)		I _{OUT} = 100mA		1.3	V
Saturation Voltage			I _{OUT} = 200mA		1.5	
			$I_{OUT} = 350 \text{mA}, V_{DD} = 7.0 \text{V}$		1.8	
Input Voltage	V _{IN(0)}				0.8	V
	V _{IN(1)}		V _{DD} = 12V	10.5]
			V _{DD} = 5.0V	3.5]
Input Resistance	R _{IN}		V _{DD} = 12V	50		kΩ
			V _{DD} = 10V	50		
			V _{DD} = 5.0V	50		1
Supply Current	I _{DD(ON)}		All Drivers ON, V _{DD} = 12V		16	mA
			All Drivers ON, V _{DD} = 10V		14]
			All Drivers ON, V _{DD} = 5.0V		8	
	I _{DD(OFF)}		All Drivers OFF, V _{DD} = 12V		2.9	1
			All Drivers OFF, V _{DD} = 5.0V		1.6	1
Clamp Diode Leakage	I _R	MIC5841A	V _R = 50V		100	μΑ
Current		MIC5842A	V _R = 80V		100	



Timing Conditions

$(T_A = 25^{\circ}C \text{ Logic Levels are V}_{DD} \text{ and V}_{SS})$	$V_{DD} = 5V$
A. Minimum Data Active Time Before Clock Pulse (Data Set-Up Time)	75 ns
B. Minimum Data Active Time After Clock Pulse (Data Hold Time)	
C. Minimum Data Pulse Width	150 ns
D. Minimum Clock Pulse Width	150 ns
E. Minimum Time Between Clock Activation and Strobe	300 ns
F. Minimum Strobe Pulse Width	100 ns
G. Typical Time Between Strobe Activation and Output Transition	500 ns

SERIAL DATA present at the input is transferred to the shift register on the logic "0" to logic "1" transition of the CLOCK input pulse. On succeeding CLOCK pulses, the registers shift data information towards the SERIAL DATA OUTPUT. The SERIAL DATA must appear at the input prior to the rising edge of the CLOCK input waveform.

Information present at any register is transferred to its respective latch when the STROBE is high (serial-to-parallel conversion). The latches will continue to accept new data as long as the STROBE is held high. Applications where the latches are bypassed (STROBE tied high) will require that the ENABLE input be high during serial data entry.

When the ENABLE input is high, all of the output buffers are disabled (OFF) without affecting information stored in the latches or shift register. With the ENABLE input low, the outputs are controlled by the state of the latches.

MIC5840 Family Truth Table

Serial		Shift Register Contents			Serial					Outpu	ıt Co	ntents					
Data Input	Clock Input	l ₁	l ₂	l ₃	 l ₈	Data Output	Strobe Input	I ₁	l ₂	l ₃	 l ₈	Output Enable	I ₁	l ₂	l ₃		l ₈
Н	7	Н	R ₁	R ₂	 R ₇	R ₇											
L		L	R ₁	R ₂	 R ₇	R ₇											
Х	一	R ₁	R ₂	R ₃	 R ₈	R ₈											
		Х	Х	Х	 Χ	Х	L	R ₁	R ₂	R ₃	 R ₈						
		P ₁	P ₂	P ₃	 P ₈	P ₈	Η	P ₁	P ₂	P ₃	 P ₈	L	P ₁	P ₂	P ₃		P ₈
								Х	Х	Х	 Х	Н	Н	Н	Н		Н

L = Low Logic Level

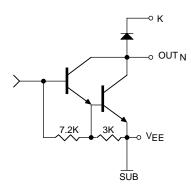
H = High Logic Level

X = Irrelevant

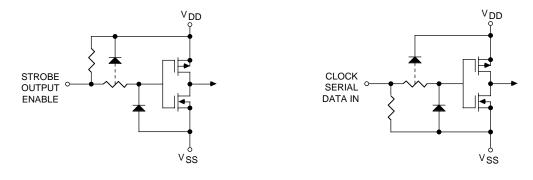
P = Present State

R = Previous State

Typical Output Driver



Typical Input Circuits



Maximum Allowable Duty Cycle (Plastic DIP)

 $V_{DD} = 5.0V$

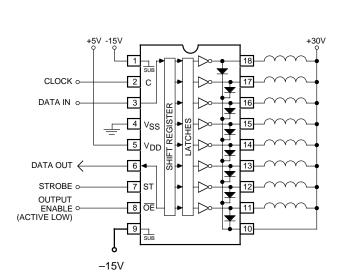
Number of Outputs ON (I _{OUT} = 200mA	Ma	x. Allowable D	outy Cycle at An	nbient Tempe	rature of
$V_{DD} = 5.0V$)	25°C	40°C	50°C	60°C	70°C
8	85%	72%	64%	55%	46%
7	97%	82%	73%	63%	53%
6	100%	96%	85%	73%	62%
5	100%	100%	100%	88%	75%
4	100%	100%	100%	100%	93%
3	100%	100%	100%	100%	100%
2	100%	100%	100%	100%	100%
1	100%	100%	100%	100%	100%

V_{DD} = 12**V**

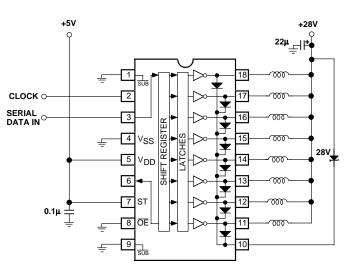
Number of Outputs ON (I _{OUT} = 200mA	Max. Allowable Duty Cycle at Ambient Temperature of								
V _{DD} = 12V)	25°C	40°C	50°C	60°C	70°C				
8	80%	68%	60%	52%	44%				
7	91%	77%	68%	59%	50%				
6	100%	90%	79%	69%	58%				
5	100%	100%	95%	82%	69%				
4	100%	100%	100%	100%	86%				
3	100%	100%	100%	100%	100%				
2	100%	100%	100%	100%	100%				
1	100%	100%	100%	100%	100%				

Typical Applications

Relay/Solenoid Driver MIC5842

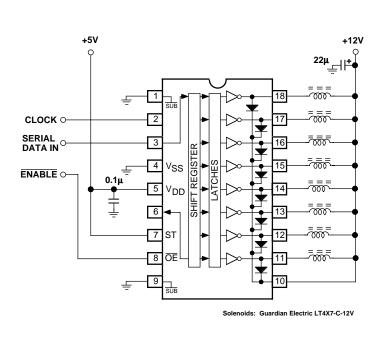


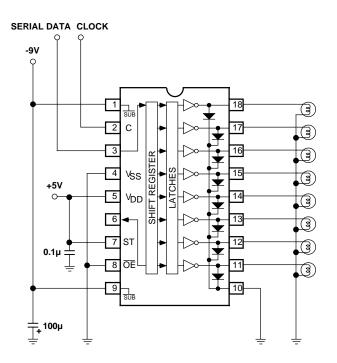
MIC5841 Hammer Driver



MIC5841 Solenoid Driver with Output Enable

MIC5841 Level Shifting Lamp Driver with Darlington Emitters Tied to a Negative Supply





Typical Applications, Continued

MIC5842 Negative/Positive Supply PIN Diode Driver Transmit/Receive Switch

